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(12) **United States Design Patent**  
**Zock**

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- (54) **PARTICLE ANALYZER**
- (71) Applicant: **Intellicyt Corporation**, Albuquerque, NM (US)
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- (73) Assignee: **Intellicyt Corporation**, Albuquerque, NM (US)
- (\*\*) Term: **14 Years**
- (21) Appl. No.: **29/459,799**
- (22) Filed: **Jul. 3, 2013**
- (51) **LOC (10) Cl.** ..... **10-04**
- (52) **U.S. Cl.**  
USPC ..... **D10/81; D10/97; D24/216; D24/232**
- (58) **Field of Classification Search**  
CPC ..... G01N 2015/1006–2015/1461; G01N 15/10–15/1463; G01N 15/02–15/06; G01N 2015/0003–2015/0096; G01N 15/00; G01N 2035/0091; G01N 2035/00435; G01N 2035/00752; G01N 15/0211; G01N 35/08; G01N 35/00; G01N 35/1074; G01N 35/1095  
USPC ..... D10/46, 75, 81, 97; D24/107, 158, 169, D24/185, 186, 216, 232–234  
See application file for complete search history.

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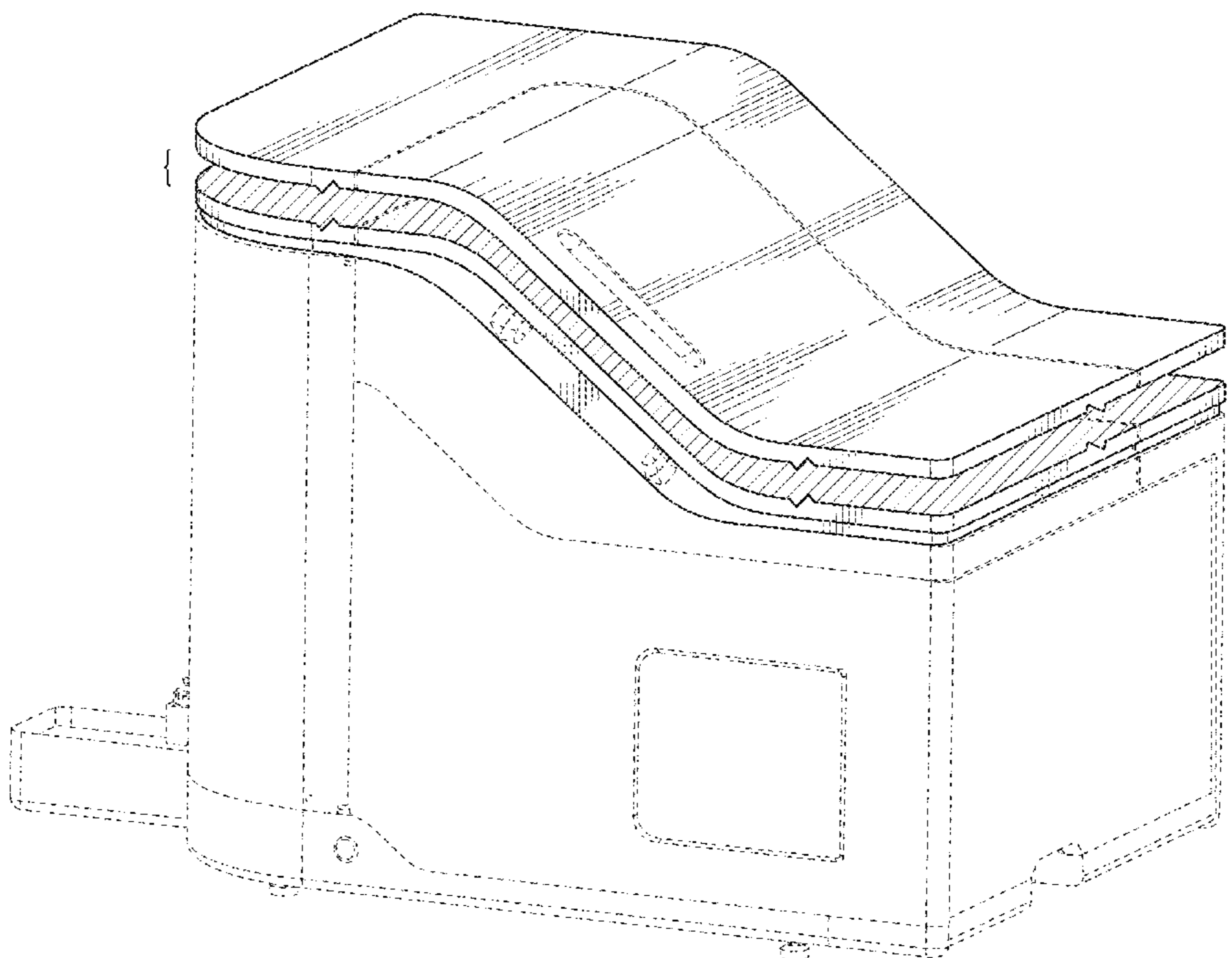
(57) **CLAIM**  
The ornamental design for a particle analyzer, as shown and described.

**DESCRIPTION**

FIG. 1 is a perspective view of the particle analyzer showing our new design;  
FIG. 2 is a front view thereof;  
FIG. 3 is a back view thereof;  
FIG. 4 is a left side view thereof;  
FIG. 5 is a right side view thereof;  
FIG. 6 is a top plan view thereof;  
FIG. 7 is a bottom plan view thereof;  
FIG. 8 is a left front perspective view thereof;  
FIG. 9 is a left front perspective view thereof; and,  
FIG. 10 is a left back perspective view thereof.  
The broken line shows environmental structure of the particle analyzer and forms no part of the claimed design. The appearance of a separation and bracket indicate indeterminate thickness.

- (56) **References Cited**  
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**1 Claim, 10 Drawing Sheets**



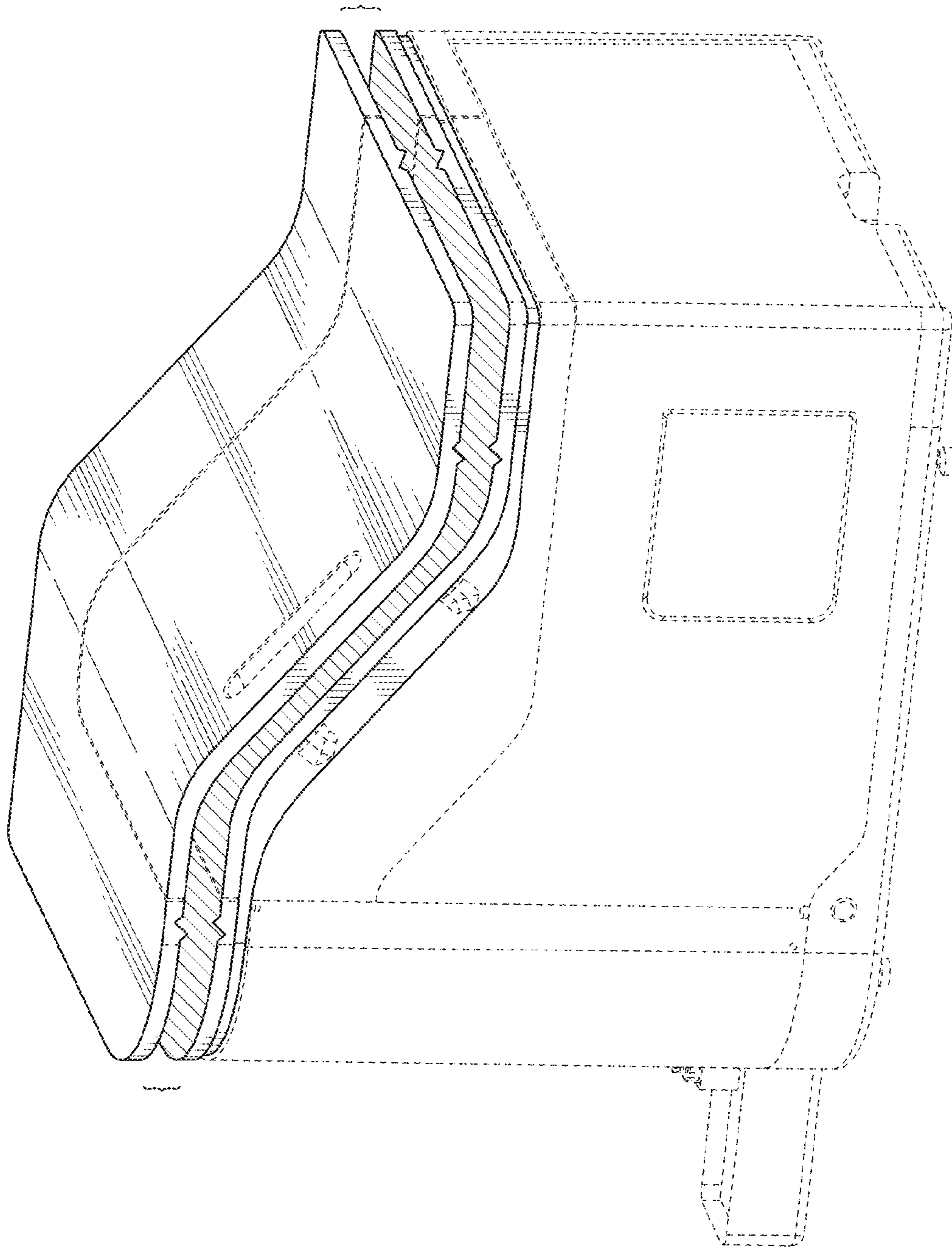


FIG. 1

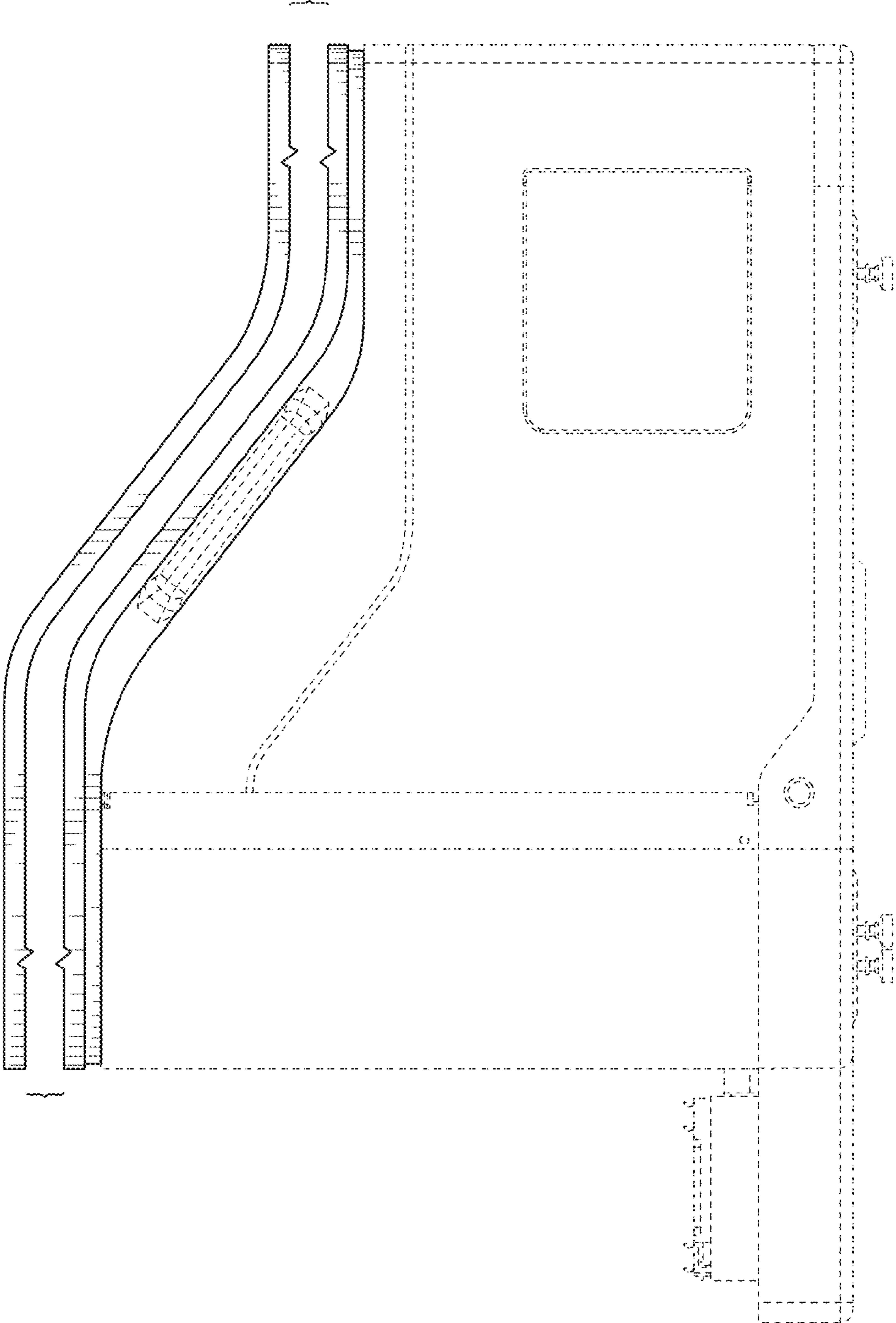


FIG. 2

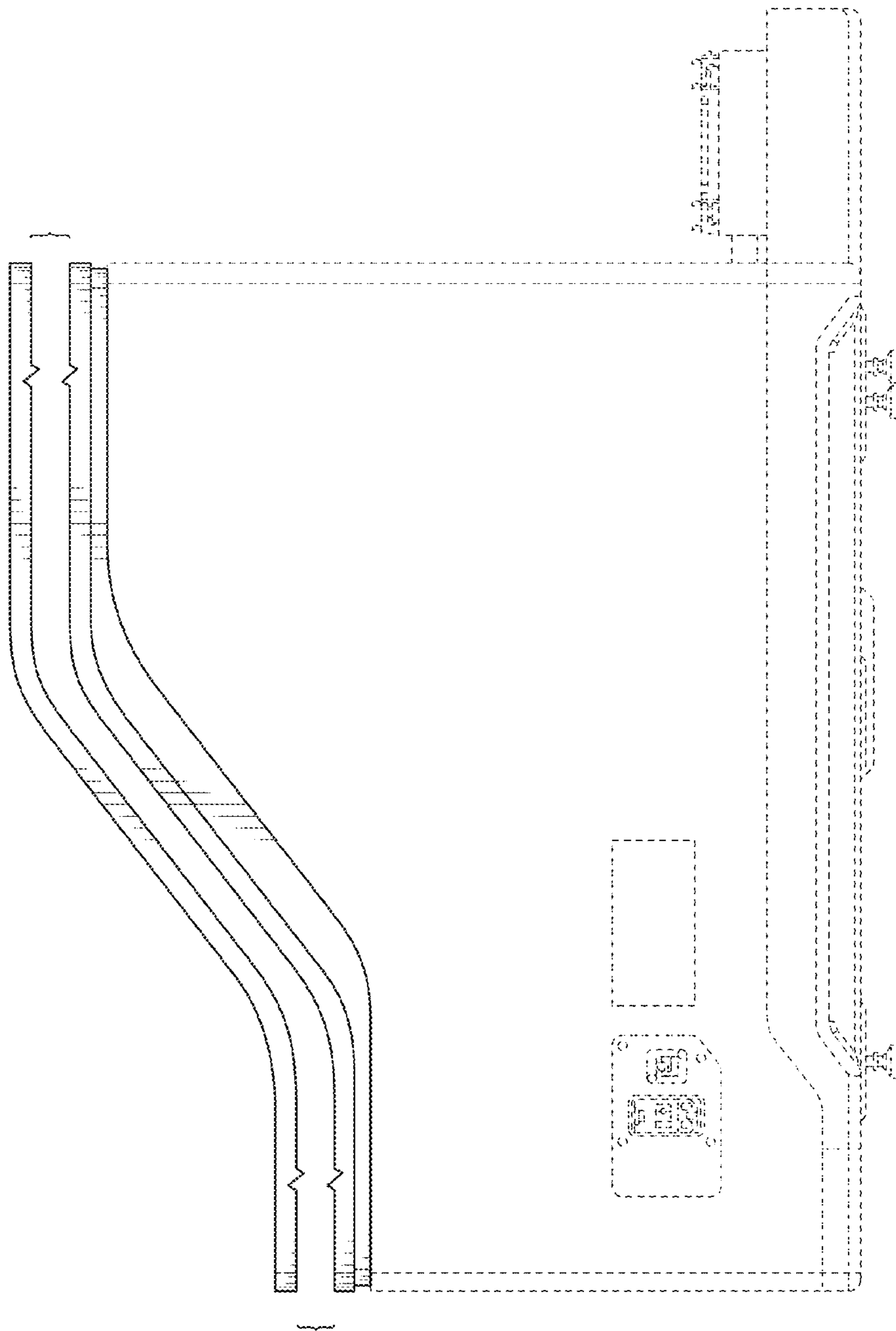


FIG. 3

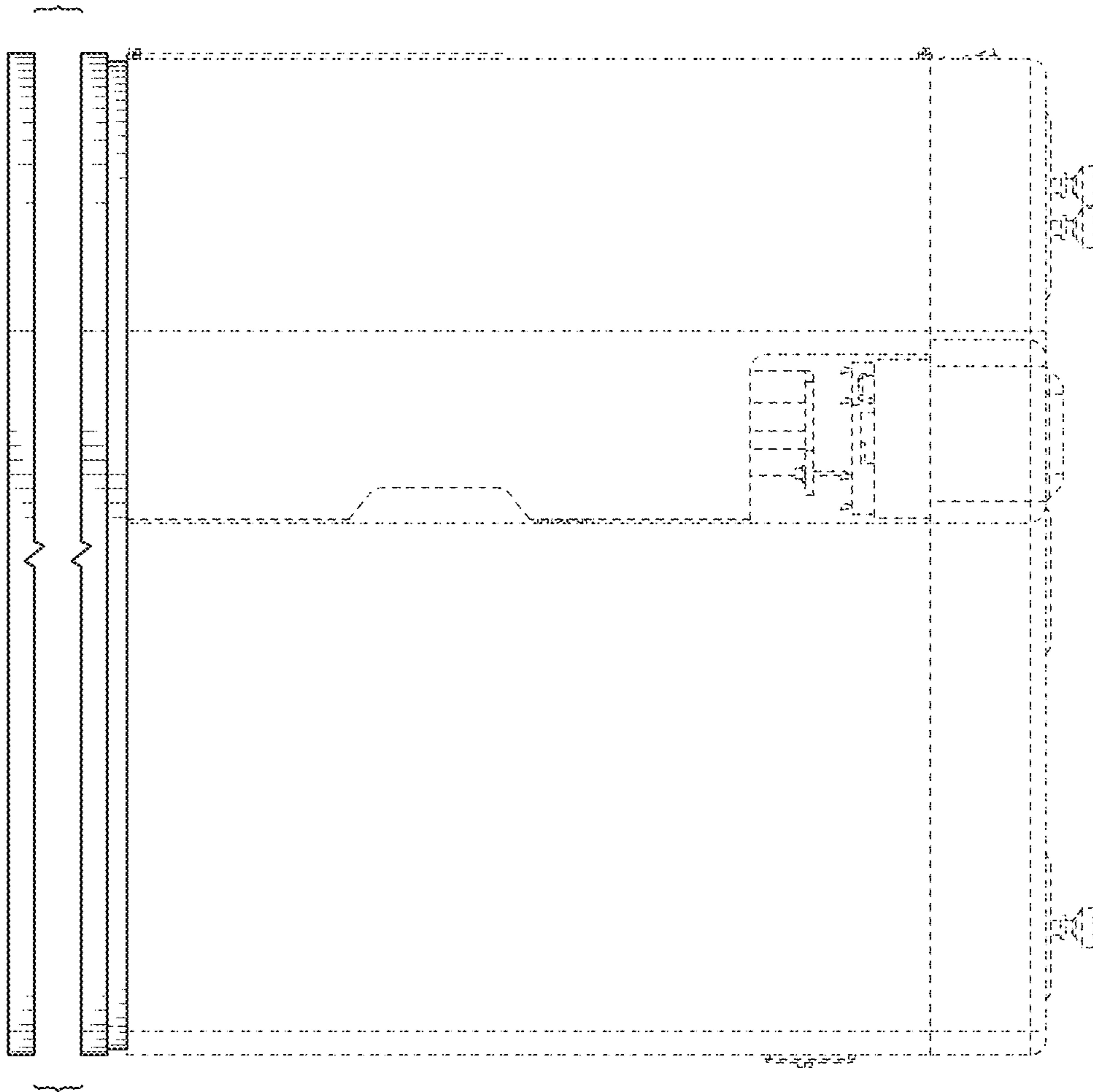


FIG. 4

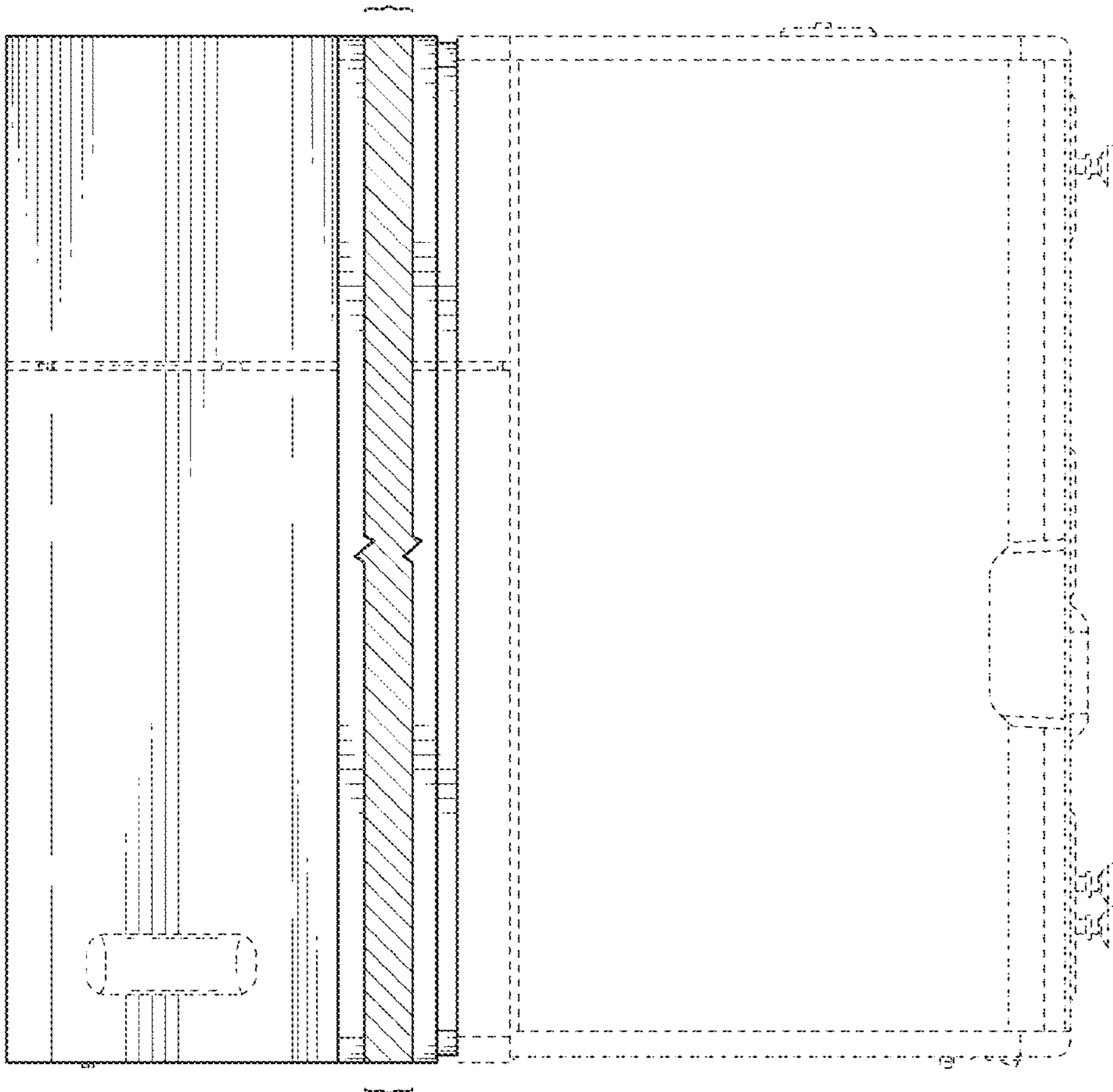


FIG. 5

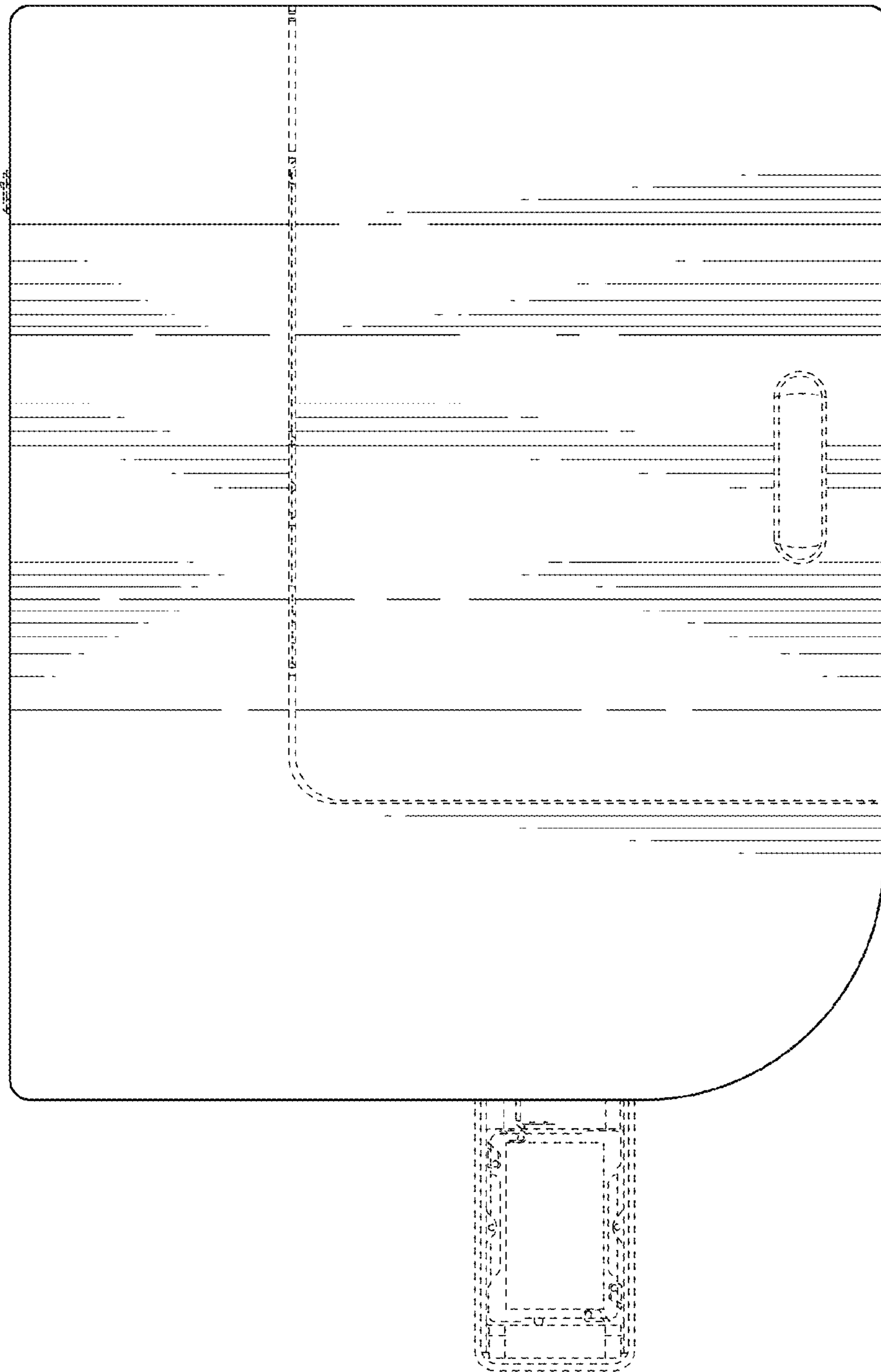


FIG. 6

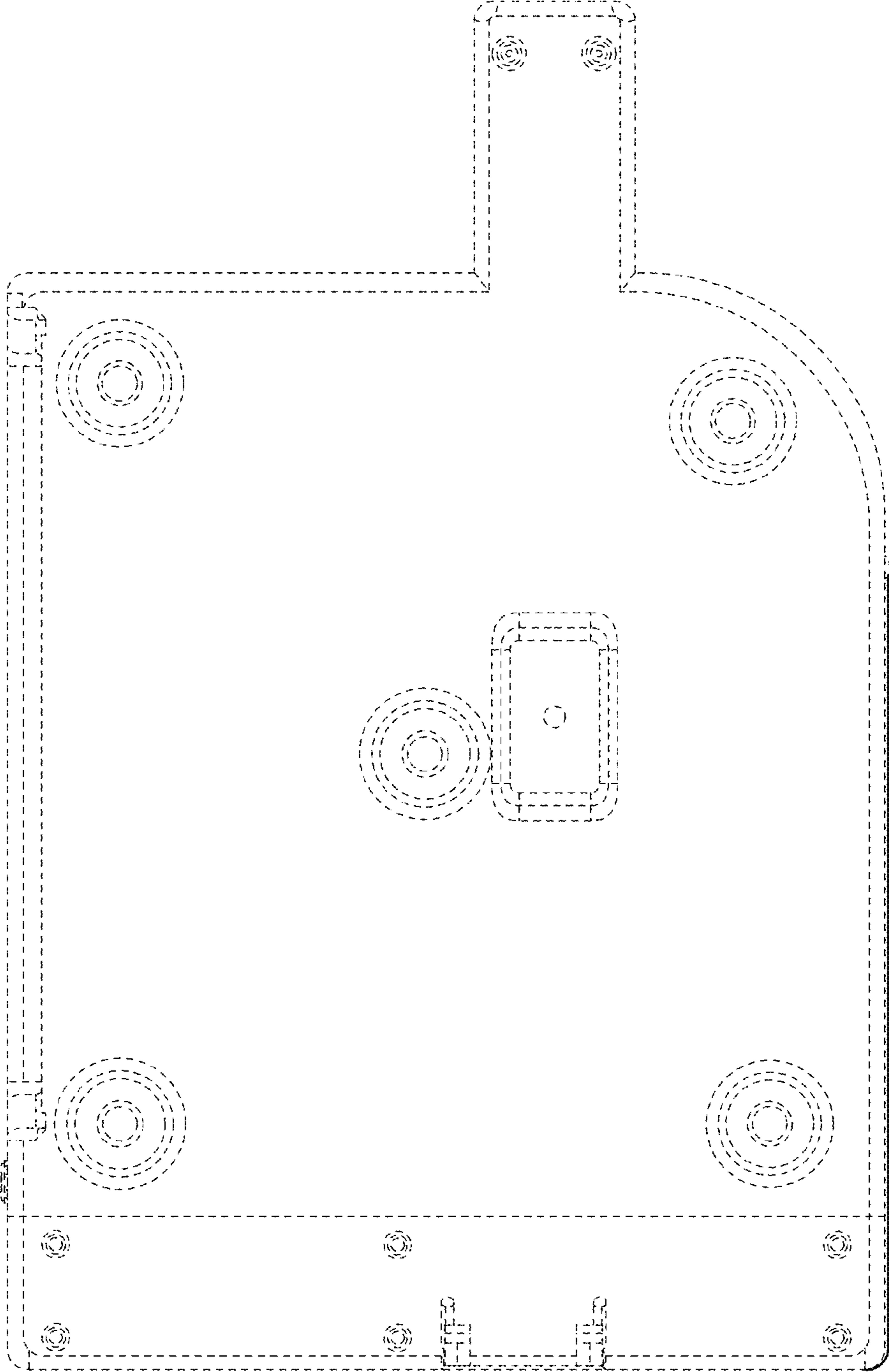


FIG. 7



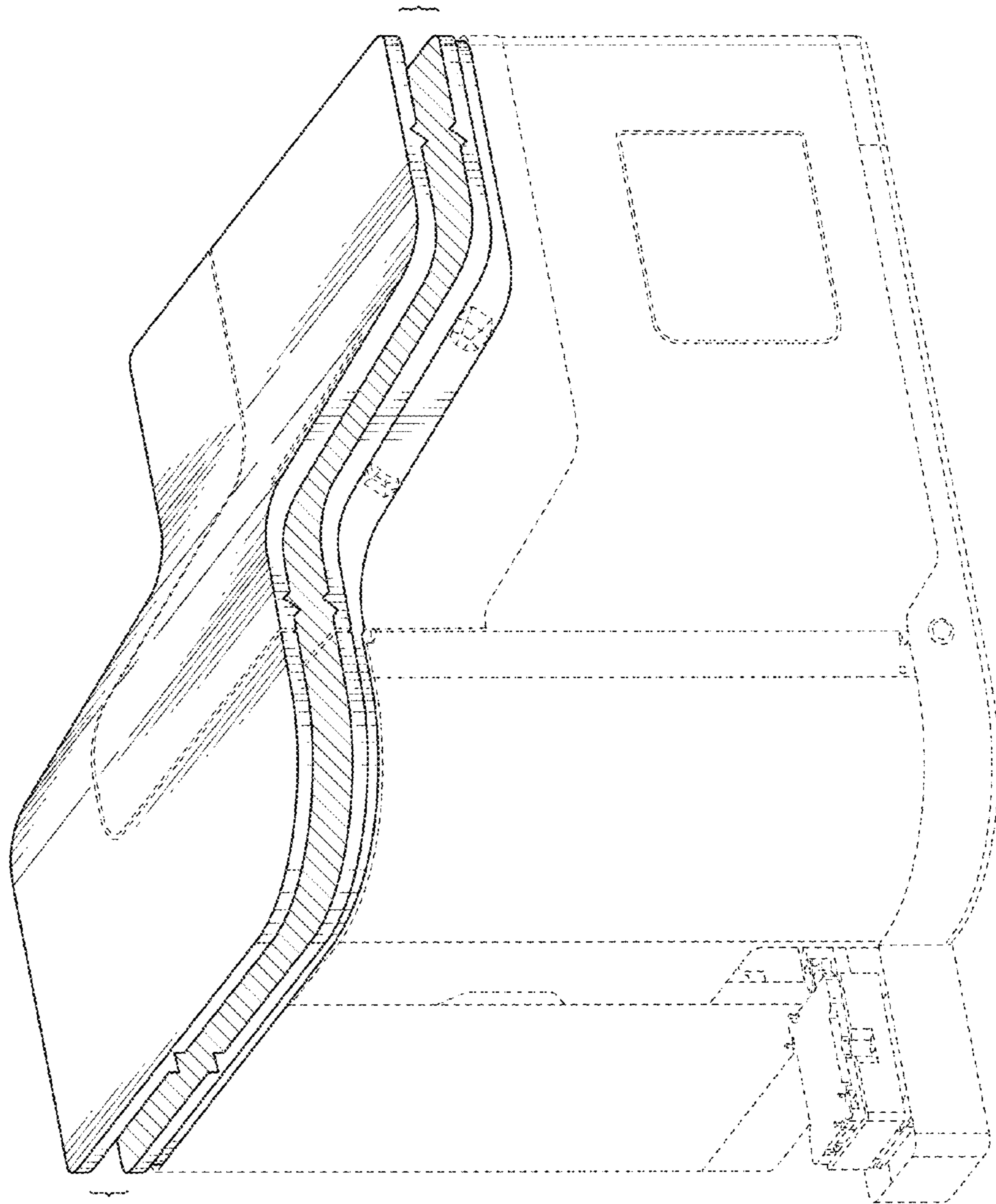


FIG. 8

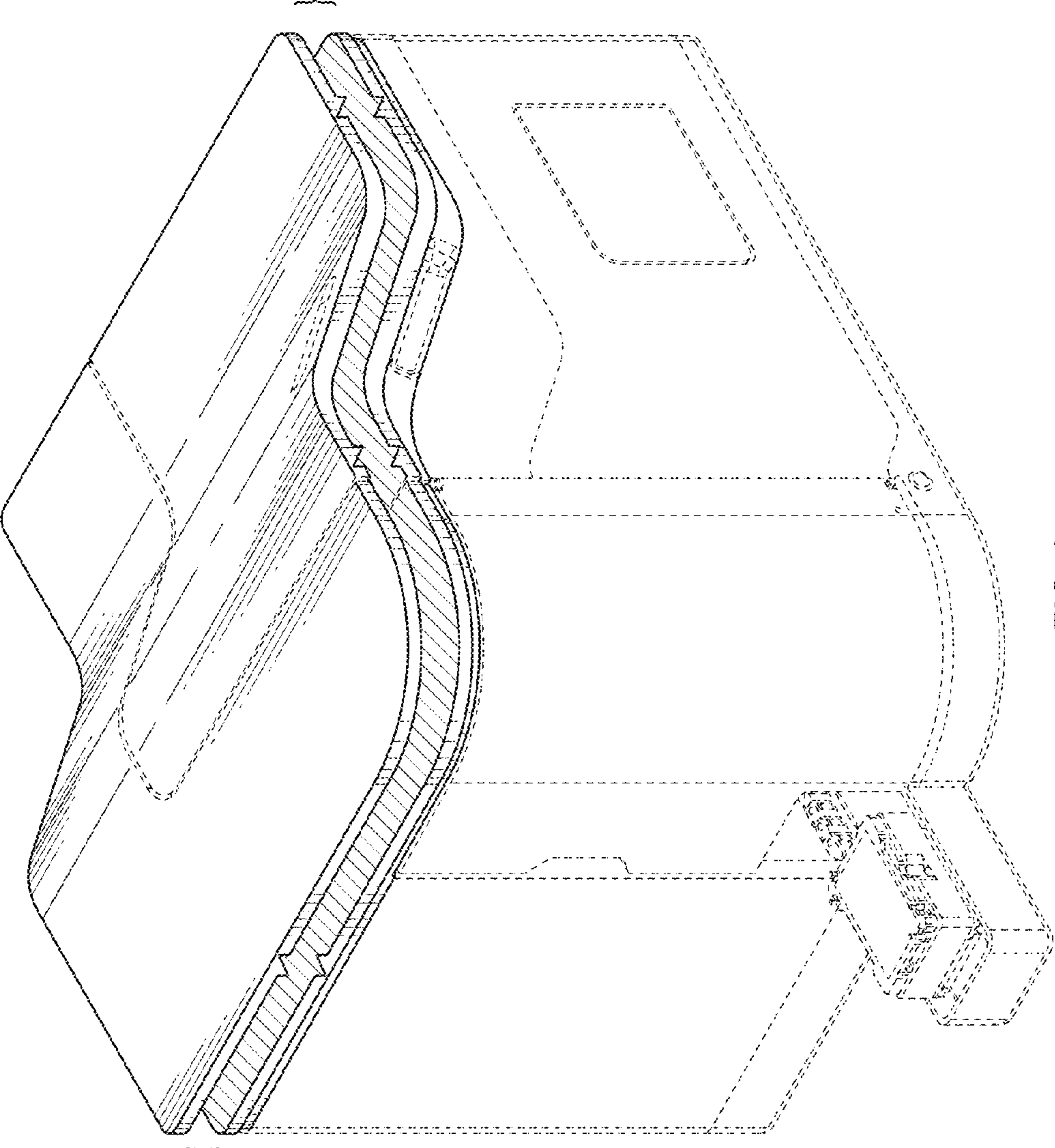


FIG. 9

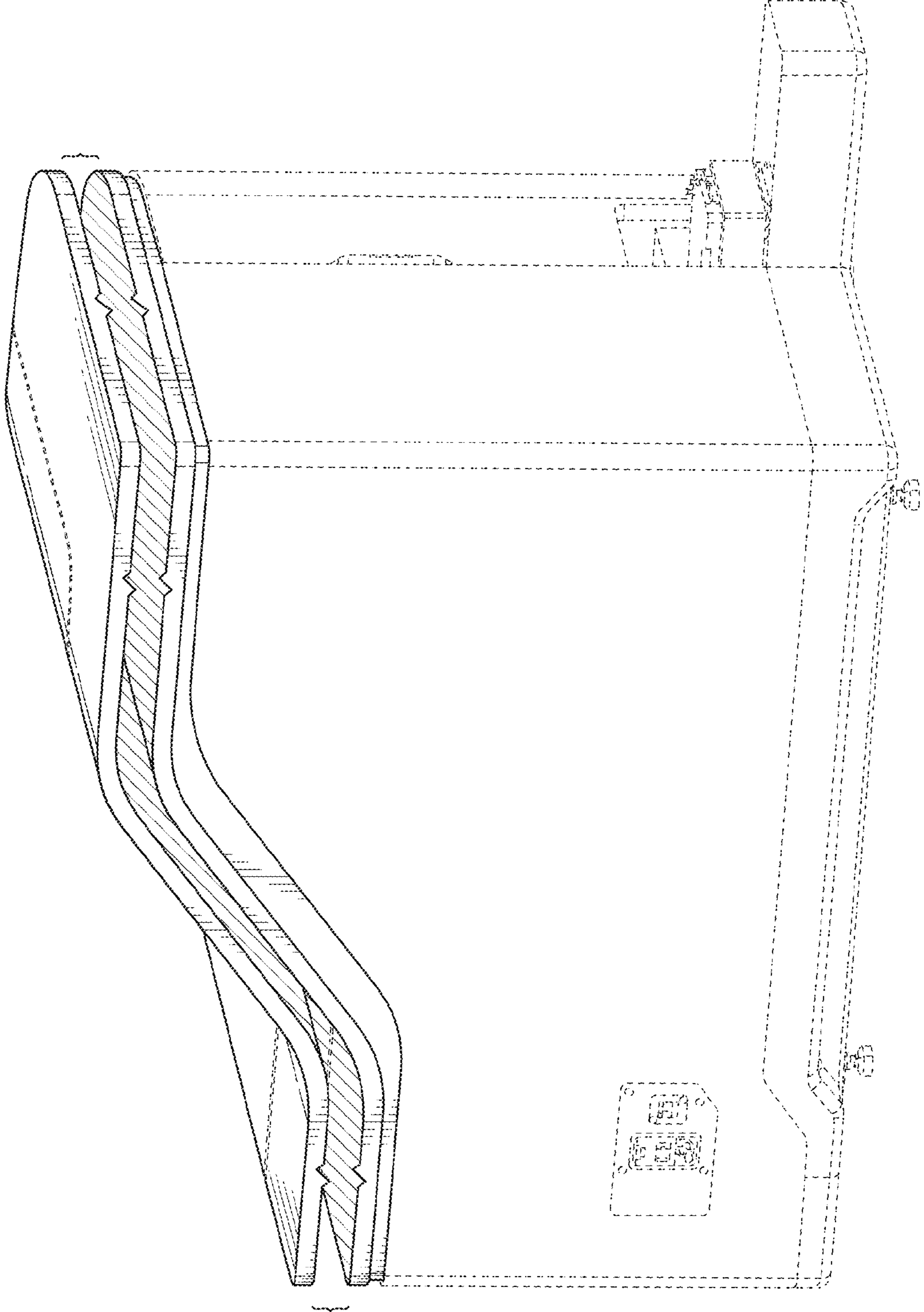


FIG. 10